

**Search Notes**

Application/Control No.

10/517,355

Examiner

David Lukton

Applicant(s)/Patent under  
Reexamination

MOK, KENNETH HUN

Art Unit

1654

**SEARCHED**

Class	Subclass	Date	Examiner
514	18	3/29/2007	<i>DL</i>
		<i>↓</i>	<i>↓</i>
530	331	<i>↓</i>	<i>↓</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
structure search, sequence search	3/29/2007	<i>DL</i>